Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/693,885	LEE ET AL.		
Examiner	Art Unit		
B. Clayton McCraw	3744		

SEARCHED					
Class	Subclass	Date	Examiner		
62	176.1, 176.6, 331, 160	2/9/2006	всм		
236	44A, 44C	2/9/2006	всм		
62	176.1	8/20/2006	всм		
62	176.6,160	8/20/2006	всм		
62	331	8/20/2006	всм		
236	44A, 44C	8/20/2006	всм		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
See 4H	fached	8/20/06	BCH		
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consulted with Primary Examiner, Marc Norman	2/9/2006	всм
Conducted Inventor Name Search	2/9/2006	всм
EAST Search Notes Attached	2/16/2006	всм
EAST Search Notes Attached	8/20/2006	всм
EAST Interference Search Attached	8/20/2006	всм